Generalization performance of support vector classifiers for density level detection

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ABSTRACT

This paper investigates the generalization performance of support vector classifiers for density level detection (DLD) when the input term belongs to a separable Hilbert space. The estimate of learning rate for DLD problem is established by Rademacher average and iterative techniques, which is independent of the assumption of covering number used in the previous literature.

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1. Introduction

A classification framework for density level detection (DLD) problem has been proposed in [11] and its error analysis has been well established in [10,6] based on the capacity assumption of covering numbers. The theoretical result is important to better understand the mathematical foundation of classification method for DLD. It is well known that the Rademacher complexity has been used successfully for mathematical analysis of machine learning algorithms, see e.g., [2,3,20]. In this paper, we consider establishing the generalization error analysis of the DLD problem by combining the Rademacher complexity with the iterative technique in [13,19,7].

Let us recall the background of the density level detection problem in Hilbert spaces (see [11,10,6]). Let (H, ‖·‖) be a separable Hilbert space (possibly infinite dimensional) and let X=H with ‖x‖≤1 for all x∈X. Let Q be an unknown data-generating distribution on X. One of the most common ways to define anomalies is by saying that anomalies are not concentrated. A reference distribution μ on X is introduced to describe the concentration of Q. Assume that Q has a density h with respect to μ, i.e., dQ=hdμ. Given ρ>0, the set {x:h(x)>ρ,x∈X} is called ρ-level set of density h. To define anomalies in terms of the concentration one only has to fix a threshold ρ>0 so that a sample x∈X is considered to be anomalous whenever h(x)>ρ. The main task of the DLD problem is to find ρ-level set {x:h(x)>ρ,x∈X}. In this paper, we assume that {x:h(x)=ρ,x∈X} is a μ-zero set and hence it is also a Q-zero set (see e.g., [9,17]).

Let S={x1,...,xk} be a training set which is drawn independently from Q. Given S, a DLD algorithm learns a function fs:X→R such that the set {x:fs(x)≥0} is a good estimate of ρ-level set. For a measurable function f:X→R, the approximation performance is measured (see [11]) by

Sρ,h,f:=μ(∥x−μ∥≥μ(∥x−h∥≥ρ)),

where ∆ denotes the symmetric difference.

Unfortunately, there is no known method to estimate Sρ,h,f from empirical data, and hence empirical comparison in terms of Sρ,h,f is difficult. To overcome this difficulty, a novel performance measure has been proposed in [11] by interpreting the DLD problem as a binary classification problem. Let Y={−1,1}. The measure is defined as below.

Definition 1. Let Q and μ be probability measures on X and S∈(0,1). Then the probability measure Q⊗μ(A) on X×Y is defined by

Q⊗μ(A)=∫X×Yμ(Ix,A(x,y)−1)μ(dx,dy),

for all measurable subsets A∈X×Y. Here IA denotes the indicator function of a set A.

From the definition we know that P=Q⊗μ can be associated with a binary classification problem where positive samples are drawn from Q and negative samples are drawn from μ.
The misclassification risk for a measurable function \( f : X \rightarrow \mathbb{R} \) and a distribution \( P \) on \( Z \times X \times Y \) is defined by
\[
\mathcal{R}_P(f) = P((x,y) : \text{sign}(f(x)) \neq y),
\]
where \( \text{sign}(t) = 1 \) if \( t > 0 \) and \( \text{sign}(t) = -1 \) otherwise.

It is well known that the Bayes classifier \( f_\lambda = \text{sign}(2P(y = 1) - 1) \) minimizes the misclassification risk \( \mathcal{R}_P(f) \). Moreover, for \( P = Q \otimes \mu \) and \( s = 1/(1 + \rho) \), \( f_\lambda = \text{sign}(h^{-1} - 1)_{[0,1]} \).

As shown in [12], \( S_{p,h}(f) \leq 0 \) if and only if \( \mathcal{R}_P(f) = \mathcal{R}_P(f_\lambda) \).

Thus, the problem of DLD can be transformed into finding a good function \( f \) such that \( \mathcal{R}_P(f) = \mathcal{R}_P(f_\lambda) \). Based on the interpretation, a kernel-based method is introduced in [11] to realize DLD.

Recall that \( K : X \times X \rightarrow \mathbb{R} \) is a Mercer kernel if it is continuous, symmetric, and positive semi-definite. The candidate reproducing kernel Hilbert space (RKHS) \( \mathcal{H}_K \) associated with a Mercer kernel \( K \) is defined as the closure of the linear span of the set of functions \( \{K(x, \cdot) : x \in X\} \), equipped with the inner product \( \langle \cdot, \cdot \rangle_K \) defined by \( \langle K(x, y) \rangle = K(x, y) \) (see [11]). The reproducing property is given by \( K(x, f) = f(x) \) for all \( x \in X \) and \( f \in \mathcal{H}_K \).

For a given positive labeled data \( T^+ = \{(x_i^+, y_i^+)\}_{i=1}^m \) drawn independently from \( Q \), the empirical quantity
\[
\frac{1}{m(1 + \rho)} \sum_{i=1}^m (1 - f(x_i^+)) + \frac{\rho}{m(1 + \rho)} \sum_{i=1}^m (1 + f(x_i^+)).
\]
is considered in [11]. As pointed out by Steinwart et al. in [11], although the measure \( \mu \) is known, the expectation \( E_{\mu}(1 + f(x))^n \) can be numerically computed through finite evaluation of \( f \) on \( T = \{(x_i^+)\}_{i=1}^m \). Here \( T = \{(x_i^+)\}_{i=1}^m \) are randomly drawn independently according to \( \mu \).

The empirical risk of \( f \) is defined as
\[
\mathcal{E}_T(f) = \frac{1}{m(1 + \rho)} \sum_{i=1}^m (1 - f(x_i^+)) + \frac{\rho}{m(1 + \rho)} \sum_{i=1}^m (1 + f(x_i^+)).
\]

The following regularized algorithm has been proposed in [11]
\[
f_T = \arg\min_{f \in \mathcal{H}} \mathcal{E}_T(f) + \lambda \|f\|_{\mathcal{H}}^2,
\]
where \( \lambda > 0 \) is a regularization parameter.

Under the assumption on covering numbers, the convergence of (1) is well understood in [10,6]. In this paper, inspired by theoretical analysis in [3,5,7], we adopt the Rademacher average as the capacity measure of hypothesis space. Dimension-free bound of capacity can be derived in terms of the structural properties of Rademacher average. Without the covering number assumption, satisfactory learning rate is obtained by combining the Rademacher complexity with the iteration technique.

The rest of this paper is organized as follows. In Section 2, we introduce the necessary definitions and present the main result on learning rate. A detailed proof of the main result is provided in Section 3.

2. Error analysis

To establish the relationship between \( S_{p,h}(f_T) \) and the excess risk \( \mathcal{R}_P(f_T) - \mathcal{R}_P(f_\lambda) \), we recall the following assumption [11,10].

**Definition 2.** Let \( \mu \) be a distribution on \( X \) and let \( h : X \rightarrow [0,1] \) be a measurable function with \( \int h \, d\mu = 1 \), i.e., \( h \) is a density with respect to \( \mu \). For \( p > 0 \) and \( 0 < q < +\infty \), we say \( h \) has \( p \)-exponent \( q \) if there exists a constant \( c > 0 \) such that for all \( t > 0 \)
\[
\mu\{(|h - h_\mu| \leq t)\} \leq C t^p.
\]

The assumption on \( h \) is closely related to the definition of Tsybakov noise in [18] for binary classification. If \( h \) has \( p \)-exponent \( q \equiv (0, +\infty) \), Theorem 10 [11] shows that there exists a constant \( c > 0 \) such that
\[
S_{p,h}(\text{sign}(f)) \leq \mathcal{C}(\mathcal{R}_P(f) - \mathcal{R}_P(f_\lambda))^{\tilde{q}(\tilde{q} - 1)}. \tag{2}
\]

According to \( \mathcal{E}_T(f) \), we introduce the expected risk with a convex loss
\[
\mathcal{E}(f) = \frac{1}{1 + \rho} E_{Q \otimes \mu}(1 - f(x))^n + \frac{\rho}{1 + \rho} E_{\mu}(1 + f(x))^n.
\]

We know that for every measurable function \( f : X \rightarrow \mathbb{R} \)
\[
\mathcal{R}_P(f) - \mathcal{R}_P(f_\lambda) \leq \mathcal{E}(f) - \mathcal{E}(f_\lambda),
\]
according to Theorem 2.1 in [21] or Theorem 9.21 in [8].

Define the data independent regularization function
\[
f_{\lambda, \rho} = \arg\min_{f \in \mathcal{H}} \mathcal{E}(f) + \lambda \|f\|_{\mathcal{H}}^2.
\]

From the definitions of \( f_T \) in (1) and \( f_\lambda \) in (4), we have
\[
\mathcal{E}(f_T) - \mathcal{E}(f_\lambda) \leq \mathcal{E}(f_T) - \mathcal{E}(f_\lambda) + \lambda \|f_T\|_{\mathcal{H}}^2 \leq S(T, \lambda) + D(\lambda),
\]
where the sample error
\[
S(T, \lambda) = \mathcal{E}(f_T) - \mathcal{E}(f_\lambda) + \mathcal{E}(f_\lambda) - \mathcal{E}(f_\lambda) \leq \mathcal{E}(f_T) - \mathcal{E}(f_\lambda)
\]
and the approximation error
\[
D(\lambda) = \|f_\lambda - f_T\|_{\mathcal{H}}^2.
\]

The bounding technique for sample error \( S(T, \lambda) \) relies on complexity measure of hypothesis function space \( \mathcal{H}_K \). To derive a dimension-free estimate, we introduce Rademacher complexity [2] as the measure of capacity.

**Definition 3.** Let \( q \) be a probability distribution on a set \( X \) and suppose that \( x_1, \ldots, x_m \) are independent samples selected according to this distribution. Let \( \mathcal{F} \) be a class of real-valued functions defined on \( X \). The empirical Rademacher average of \( \mathcal{F} \) is defined by
\[
\hat{R}_m(\mathcal{F}) = E_{\xi \sim q^m} \left\{ \sup_{f \in \mathcal{F}} \frac{1}{m} \sum_{i=1}^m \xi(f(x_i)) : x_1, \ldots, x_m \right\},
\]
where \( \xi_1, \ldots, \xi_m \) are independent uniform \{± 1\}-valued random variables. The Rademacher complexity of \( \mathcal{F} \) is \( R_m(\mathcal{F}) = E \hat{R}_m(\mathcal{F}) \).

In this paper, we adopt the following condition for approximation error, which has been extensively used in the literature. See e.g., [4,19,8,20,6].

**Definition 4.** We say the target function \( f_\lambda \) can be approximated with exponent \( 0 < p < 1 \) in \( \mathcal{H}_K \) if there exists a constant \( c_p \geq 1 \), such that
\[
D(\lambda) \leq c_p \rho^p, \quad \forall \lambda > 0. \tag{6}
\]

It is now a position to present our main result on learning rate. The detailed proof will be given in the next section.

**Theorem 1.** Let \( \rho > 0 \). Let \( \mu \) and \( Q \) be distributions on \( X \) such that \( Q \) has a density \( h \) with respect to \( \mu \). For \( s = 1/(\rho + 1) \), we write \( P = Q \otimes \mu \). Assume that \( h \) has \( p \)-exponent \( q \) and \( f_\lambda \) can be approximated with exponent \( \beta \) in \( \mathcal{H}_K \). Then, for any \( 0 = \delta < 1 \), choosing \( \lambda = (1/\sqrt{m + 1}/\sqrt{n})\sqrt{q/(q + 1)} \), we have with confidence \( 1 - \delta \)
\[
S_{p,h}(f_T) \leq C \left( \frac{\log(1 + k_0)}{1 + \beta} + \frac{1}{1 + \beta} \right)^{q/(q + 1)} \left( 1 + \frac{1}{\sqrt{n}} \right)^{q/(q + 1) - q/2^k} = O(k). \tag{7}
\]

From the result in Theorem 1, we know that the balance of samples is crucial to reach the fast learning rate. In particular, learning rate of \( f_T \) can be close to \( O(n^{-q/(4^k + 4)}) \) when \( m = O(n) \) and \( \beta \rightarrow 1 \). It is worth noting that the presented convergence analysis is independent of the assumption on covering numbers in [6].
Now we give some comparisons on learning rates for any $\epsilon > 0$ and $m = O(n)$. It has been shown in [10] that if the density $h$ has both $p$-exponent $q$ and geometric $p$-exponent $\alpha \in [0, 1)$, then the learning rates of $f_T$ is $O((n^{1/(1+q+2\alpha+1)})^r)$ for $\alpha < (q + 2)/2$ and $O(n^{-q+2\alpha+1+q+2\alpha+1})$ otherwise. We can observe that our estimate of learning rate is faster than $O(n^{-q+2\alpha+1+q+2\alpha+1})$ when $\alpha < (q + 2)/2$. In fact, by using the iterative technique, we can also improve the previous estimates on generalization error in [6].

Along the line of the present work, further research direction may establish the generalization estimate of the DLD problem with non-i.i.d samples [14,15] and with different analysis techniques [13,16].

3. Proof of Theorem 1

We introduce some properties of Rademacher complexity (see [2]) which are used in the sample error estimation.

**Lemma 1.** Let $G$, $G_1$, $G_2$ be the classes of real functions. Then

1. $\mathcal{R}_m(G) \subseteq \mathcal{R}(G)$ where $|G| = |\{ f : f \in G \}|$.
2. $\mathcal{R}_m(G_1 \oplus G_2) \subseteq \mathcal{R}(G_1) + \mathcal{R}(G_2)$ where $G_1 \oplus G_2 = \{ g_1 + g_2 : (g_1, g_2) \in G_1 \times G_2 \}$.
3. If $\phi : \mathbb{R} \to \mathbb{R}$ is Lipschitz with constant $L_\phi$ and satisfies $\phi(0) = 0$, then $\mathcal{R}_m(\{ \phi \circ G \}) \leq L_\phi \mathcal{R}_m(G)$.

Now we give the estimate of Rademacher complexity for hypothesis function spaces in RKHS. The analysis technique used here is the same as Lemma 2.1 in [5]. We recall the key steps of proof for completeness.

**Lemma 2.** Define $F_\gamma = \{ f \in \mathcal{H}_K, \| f \|_K \leq \gamma \}$ and $\kappa = \sup_{x \in K} \sqrt{K(x,x)}$. Then, $\mathcal{R}_m(F_\gamma) \leq \kappa/\sqrt{n}$.

**Proof.** Based on the reproducing property of $f \in F_\gamma$, we have

$$\mathcal{R}(F_\gamma) = \mathcal{E}_n \left( \sup_{f \in F_\gamma} \frac{1}{n} \sum_{i=1}^{n} \sigma_i (f, K(x_i)) \right) \leq \mathcal{E}_n \left( \left\| \frac{1}{n} \sum_{i=1}^{n} \sigma_i K(x_i) \right\|_F \right) = \frac{\kappa}{\sqrt{n}} \mathcal{E}_n \left( \left[ \frac{1}{n} \sum_{i=1}^{n} \sigma_i \sigma_j K(x_i, x_j) \right]^{1/2} \right) \leq \frac{\kappa}{\sqrt{n}}. \quad \square$$

Note that for all $f \in F_\gamma$,

$$|\mathcal{E}(f) - \mathcal{E}_T(f)| \leq \frac{1}{1 + \rho} |\mathcal{E}_{x_i}(1 - f(x_i))_+ - \mathcal{E}_T(f)| + \frac{\rho}{1 + \rho} |\mathcal{E}_{x_i}(1 + f(x_i))_+ - \mathcal{E}_T(f)|,$$

where $\mathcal{E}_T(f) = (1/n) \sum_{i=1}^{n} (1 - f(x_i))_+$ and $\mathcal{E}_{x_i}(f) = (1/m) \sum_{j=1}^{m} (1 + f(x_j))_+$.

Now we turn to consider the two terms on the right side based on Rademacher average technique. The upper bound of sample error is presented as below.

**Proposition 1.** For any $f \in F_\gamma$, with probability at least $1 - \delta$, there holds

$$|\mathcal{E}(f) - \mathcal{E}_T(f)| \leq 2 \sqrt{2 \ln \frac{2}{\delta}} \left( \frac{1}{1 + \rho} \frac{\sqrt{m}}{\sqrt{n}} \right) + \frac{\rho}{1 + \rho} |\mathcal{E}_{x_i}(1 + f(x_i))_+ - \mathcal{E}_T(f)|.$$

**Proof.** For each $f \in F_\gamma$, we have $\|f\|_K \leq \delta$. Let $\hat{T}$ be the same copy $T$ with kth sample replaced by sample $x_k$. Then

$$|\mathcal{E}_{x_i}(1 - f(x_i))_+ - \mathcal{E}_T(f)| = \mathcal{E}_{x_i}(1 - f(x_i))_+ - \mathcal{E}_T(f) + \mathcal{E}_T(f) - \mathcal{E}_{x_i}(1 - f(x_i))_+ \leq \frac{2 \sqrt{2 \ln \frac{2}{\delta}}}{\sqrt{n}} \mathcal{E}_{x_i}(1 - f(x_i))_+ + \kappa/\sqrt{n},$$

McDiarmid's inequality implies that with probability at least $1 - \delta/2$

$$\mathbb{E} \sup_{f \in F_\gamma} |\mathcal{E}_{x_i}(1 - f(x_i))_+ - \mathcal{E}_T(f)| \leq 2 \mathbb{E} \sup_{f \in F_\gamma} \left( \mathcal{E}_{x_i}(1 - f(x_i))_+ + \kappa/\sqrt{n} \right) \leq 2 \mathbb{E} \left( \frac{\kappa}{\sqrt{n}} \right) + 4 \mathbb{E} \left( \frac{\kappa}{\sqrt{n}} \right) \leq 2 \mathcal{R}_m(F_\gamma) \frac{4\kappa}{\sqrt{n}}.$$

By combining (8) and (9), and Lemma 2, we have with probability at least $1 - \delta/2$

$$\sup_{f \in F_\gamma} |\mathcal{E}_{x_i}(1 - f(x_i))_+ - \mathcal{E}_T(f)| \leq (4 + 2 \kappa \sqrt{2 \ln \frac{2}{\delta}}) \frac{1}{\sqrt{n}}. \quad (10)$$

With the same fashion as above, we also have that

$$\sup_{f \in F_\gamma} |\mathcal{E}_{x_i}(1 + f(x_i))_+ - \mathcal{E}_T(f)| \leq (4 + 2 \kappa \sqrt{2 \ln \frac{2}{\delta}}) \frac{1}{\sqrt{m}}$$

holds with probability at least $1 - \delta/2$. The desired result follows by combining (7) with (10). $\square$

For $R > 1$, we denote $\forall (R) = \{ T : (T^+, T^-) \in \mathcal{F}_x \mathbb{E}^\infty, T^- \in \mathbb{E}^m, \|f_T\|_K \leq R \}$. Also, we denote $\Omega_T = \mathcal{E}(T^+) - \mathcal{E}(T^-) + \lambda \|f_T\|^2$.

**Lemma 3.** Denote $V_R = (V_R^+, V_R^-)$, where $V_R^+ \in \mathbb{E}^m$, $V_R^- \in \mathbb{E}^m$. For all $t > 0$, there exists a set $V_R$ with $P(V_R) \geq 4e^{-t}$ such that, for all $\forall (R) V_R$

$$\Omega_T \leq 4t \left( R + \frac{D(\lambda)}{4} \right) + 8 + 2 \sqrt{t} \left( R + \frac{D(\lambda)}{4} \right).$$
Choosing a constant $k_0$ such that $\lambda^{(p+1)/2} = O(k)$, we get for $Te \in W(R^{k_0})$
\[ ||f_T|| \leq 2e \sqrt{\lambda(\lambda^{(p+1)/2} - 2\lambda^{(p+1)/2})}. \]
Together with (11) and taking $t = \ln(k_0 + 1/\delta)$, we have with a probability at most $1-\delta$
\[ \mathcal{E}(f_T) - \mathcal{E}(f_{\lambda_T}) \leq C \left( \ln \left( \frac{k_0 + 1}{\delta} \right) \left( \frac{1}{\sqrt{m}} + \frac{1}{\sqrt{n}} \right)^{(p+1)/2} \right). \]
Connecting this inequality with (2) and (3) derives the desired result. \hspace{1cm} \Box

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